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				Application Number	10/558,438	
INFORMATION DISCLOSURE				Filing Date	March 19, 2007	
l s	TATEMENT E	3Y /	APPLICANT	First Named Inventor	Koon-Seok Lee	
				Art Unit	2477	
(use as many sheets as necessary)				Examiner Name	Daniel D. Mitchell	
Sheet	1	of	1	Attorney Docket Number	7950.046.00	

	U.S. PATENT DOCUMENTS						
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where		
Initials*	No.1	Number-Kind Code <sup>2</sup> (if known)	MM-DD-YYYY	Applicant of Cited Document	Relevant Passages or Relevant Figures Appear		
	AA	US 4,928,245	05-22-1990	Moy et al.			
	AB	US 5,551,001	08-27-1996	Cohen et al.			
	AC	US 5,794,037	08-11-1998	David W. Young			
	AD	US 5,808,885	09-15-1998	Dew et al.			
	AE	US 5,859,847	01-12-1999	Dew et al.			
	AF	US 6,078,952	06-20-2000	Fielding et al.			
	AG	US 6,615,243 B1	09-02-2003	Megeid et al.			
	АН	US 6,854,053 B2	02-08-2005	Burkhardt et al.			
	ΑI	US 6,934,740 B1	08-23-2005	Lawande et al.			
	AJ	US 7,058,722 B2	06-06-2006	Ikami et al.			
	AK	US 2002/0118696 A1	08-29-2002	Yukinori Suda			
	AL	US 2002/0120763 A1	08-29-2002	Miloushev et al.			
	AM	US 2002/0165989 A1	11-07-2002	Hiroshi Etoh			
	AN	US 2002/0193144 A1	12-19-2002	Belski et al.			
	AO	US 2003/0051053 A1	03-13-2003	Vasko et al.			
	AP	US 2003/0054809 A1	03-20-2003	Bridges et al.			
	AQ	US 2004/0111490 A1	06-10-2004	Im et al.			
	AR	US 2004/0205309 A1	10-14-2004	Naoki Watanabe			
	AS	US 2006/0047677 A1	03-02-2006	Lin et al.			
	AT	US 2008/0222325 A1	09-11-2008	Ishino et al.			

	FOREIGN PATENT DOCUMENTS							
		Foreign Patent Document	Publication	Name of Patentee or	Pages, Columns, Lines,			
Examiner Initials*	Cite No. <sup>1</sup>	Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)	Date MM-DD-YYYY	Applicant of Cited Document	Where Relevant Passages or Relevant Figures Appear	$L_{e}$		
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	NON PATENT LITERATURE DOCUMENTS					
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Examiner Signature	/Daniel Mitchell/	Date Considered	01/28/2011